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Diagnostics and Fault Tolerance in DC-DC Converters and Related Industrial Electronics Technologies

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Message from the Guest Editors

Dear Colleagues,

The deployment of DC energy systems is an attractive alternative to conventional AC-based energy distribution systems, improving the efficiency of energy supplies and promoting renewable energies. Within DC energy systems, industrial electronics and particularly DC-DC converters are the key technologies that establish the interface between the multiple individual units of DC energy systems. Semiconductors and electrolytic capacitors, as critical components of DC-DC power converters, are particularly susceptible to suffering faults, which have a critical impact on converter operation. implementation of diagnostic, prognostic, and faulttolerant strategies, which are able to effectively deal with the multiple failure modes prone to occurring in DC-DC converters, is a challenging goal and is yet to be fully achieved. This Special Issue focuses on the discussion of emerging solutions suitable for leveraging the availability, reliability, and robustness of DC-DC industrial power electronics technologies.











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Message from the Editor-in-Chief

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